

MOSFET - Power, Single N-Channel, TOLL 60 V, 0.75 mΩ, 470 A

NVBLS0D7N06C

Features

- Low R_{DS(on)} to Minimize Conduction Losses
- Low Q_G and Capacitance to Minimize Driver Losses
- Lowers Switching Noise/EMI
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V_{DSS}	60	V
Gate-to-Source Voltage	€		V _{GS}	±20	V
Continuous Drain		T _C = 25°C	I _D	470	Α
Current R _{0JC} (Note 2)	Steady	T _C = 100°C		332	
Power Dissipation	State	T _C = 25°C	P_{D}	314	W
R _{θJC} (Note 2)		T _C = 100°C		157	
Continuous Drain		T _A = 25°C	I _D	54	Α
Current R _{0JA} (Notes 1, 2)	Steady	T _A = 100°C	1	38	
Power Dissipation	State	T _A = 25°C	P_{D}	4.2	W
R _{θJA} (Notes 1, 2)		T _A = 100°C		2.1	
Pulsed Drain Current	$T_A = 25^{\circ}C, t_p = 10 \mu s$		I _{DM}	900	Α
Operating Junction and Storage Temperature Range			T _J , T _{stg}	-55 to +175	°C
Source Current (Body Diode)			I _S	260	Α
Single Pulse Drain-to-Source Avalanche Energy (I _{L(pk)} = 40 A)			E _{AS}	800	mJ
Lead Temperature Soldering Reflow for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

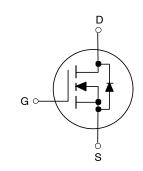
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State (Note 2)	$R_{\theta JC}$	0.48	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	36	

- 1. Surface-mounted on FR4 board using a 1 in² pad size, 2 oz. Cu pad.
- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX
60 V	0.75 mΩ @ 10 V	470 A





H-PSOF8L CASE 100CU

ORDERING INFORMATION

Device	Package	Shipping [†]
NVBLS0D7N06C	H-PSOF8L (Pb-Free)	2000 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

Table 1. ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

Parameter	Symbol	Test Conditions		Min	Тур	Max	Units
OFF CHARACTERISTICS	•			•			•
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	I _D = 250 μA, \	V _{GS} = 0 V	60			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J	I _D = 661 μA, r	ef to 25°C		26.5		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 60 V,	T _J = 25°C			10	μΑ
		$V_{GS} = 0 V$	T _J = 125°C			100	μΑ
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V ₀	_{SS} = 20 V			100	nA
ON CHARACTERISTICS (Note 3)							
Gate Threshold Voltage	V _{GS(th)}	$V_{GS} = V_{DS}, I_{D}$	= 661 μΑ	2.0	2.8	4.0	V
Negative Threshold Temperature Coefficient	V _{GS(th)} /T _J	I _D = 661 μA, r	ef to 25°C		9.8		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V,	I _D = 80 A		0.56	0.75	mΩ
Forward Transconductance	9FS	V _{DS} = 10 V, I	D = 80 A		310		S
CHARGES & CAPACTIANCES				-			
Input Capacitance	C _{iss}	$V_{GS} = 0 \text{ V}, V_{DS} = 30 \text{ V}, f = 10 \text{ kHz}$			13730		pF
Output Capacitance	C _{oss}				6912		pF
Reverse Transfer Capacitance	C _{rss}				92		pF
Total Gate Charge	Q _{G(tot)}	$V_{GS} = 10 \text{ V}, V_{DS} = 30 \text{ V},$ $I_D = 80 \text{ A}$			170		nC
Threshold Gate Charge	Q _{G(th)}				39		nC
Gate-to-Source Charge	Q_{gs}				62		nC
Gate-to-Drain Charge	Q_{gd}				16		nC
SWITCHING CHARACTERISTICS, V _{GS} = 10	V (Note 3)						
Turn-On Delay Time	t _{d(on)}	V_{GS} = 10 V, V_{DS} = 30 V, I_{D} = 80 A, R_{G} = 6 Ω			37		ns
Rise Time	t _r	I _D = 80 A, H	$G = 6 \Omega$		57		ns
Turn-Off Delay Time	t _{d(off)}				146		ns
Fall Time	t _f				105		ns
DRAIN-SOURCE DIODE CHARACTERIST	cs				-		-
Forward Diode Voltage	V_{SD}	I _S = 80 A, V _{GS} = 0 V	T _J = 25°C		0.79	1.2	V
	ļ ļ	I _S = 80 A, V _{GS} = 0 V	T _J = 125°C		0.66		V
Reverse Recovery Time	t _{rr}	V_{GS} = 0 V, dI_S/d_t = 100 A/ μ s, I_S = 66 A			132		ns
Charge Time	t _a				64		ns
Discharge Time	t _b				68		ns
Reverse Recovery Charge	Q _{rr}				386		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

3. Switching characteristics are independent of operating junction temperatures

TYPICAL CHARACTERISTICS

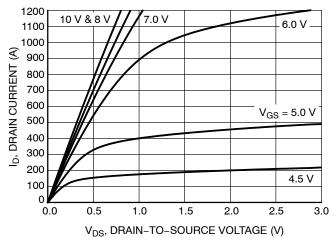


Figure 1. On-Region Characteristics

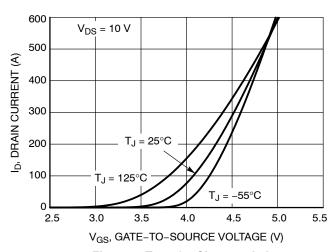


Figure 2. Transfer Characteristics

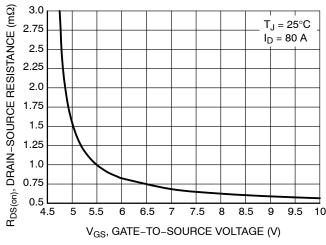


Figure 3. On-Resistance vs. V_{GS}

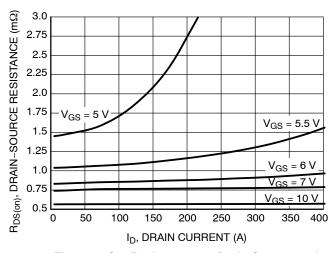


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

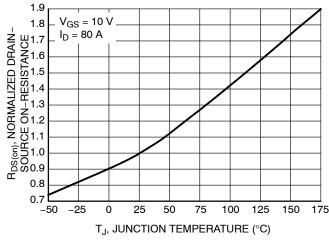


Figure 5. On–Resistance Variation with Temperature

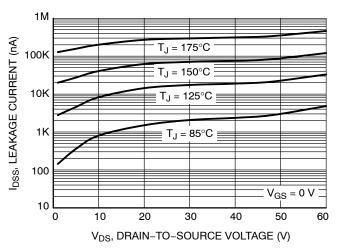


Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL CHARACTERISTICS

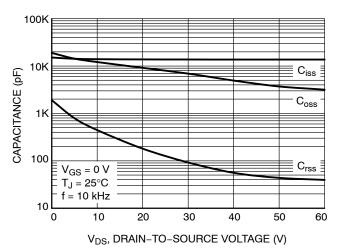


Figure 7. Capacitance Variation

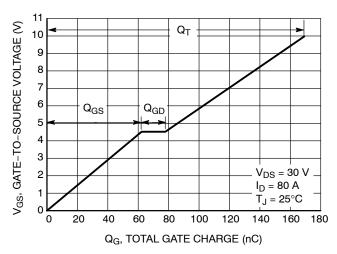


Figure 8. Gate-to-Source Voltage vs. Total Gate Charge

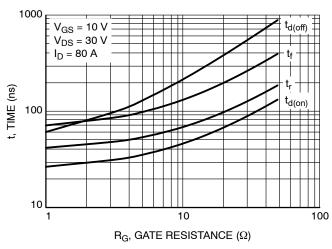


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

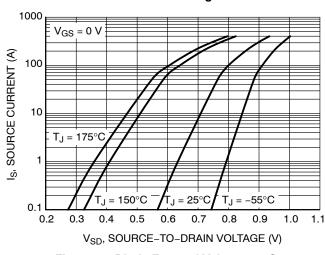


Figure 10. Diode Forward Voltage vs. Current

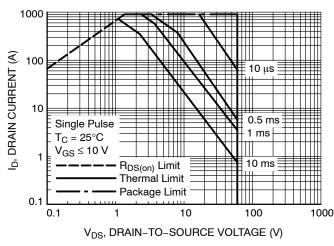


Figure 11. Maximum Rated Forward Biased Safe Operating Area

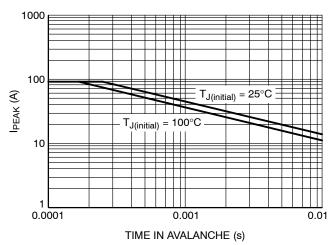


Figure 12. I_{PEAK} vs. Time in Avalanche

TYPICAL CHARACTERISTICS

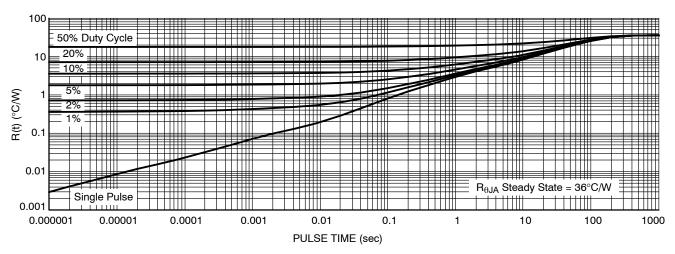
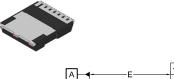


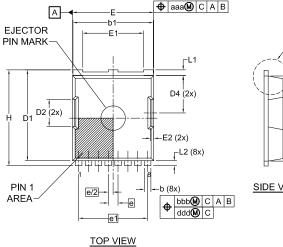
Figure 13. Thermal Characteristics (Junction-to-Ambient)

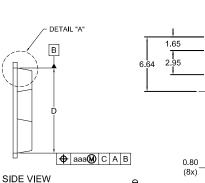


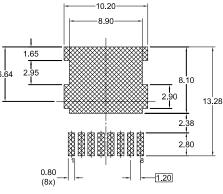


H-PSOF8L 11.68x9.80 CASE 100CU **ISSUE C**

DATE 22 MAY 2023



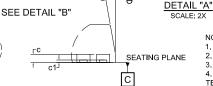




LAND PATTERN RECOMMENDATION

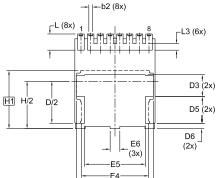
*FOR ADDITIONAL INFORMATION ON OUR PB-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ON SEMICONDUCTOR SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRM/D.

Α1 eee C FRONT VIEW



SCALE: 2X





BOTTOM VIEW

- 1. PACKAGE STANDARD REFERENCE: JEDEC MO-299, ISSUE A. 2. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
- 3. CONTROLLING DIMENSION: MILLIMETERS. 4. COPLANARITY APPLIES TO THE EXPOSED WELL AS THE
- 5. DIMENSIONS D1 AND E1 DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS.
- 6. SEATING PLANE IS DEFINED BY THE TERMINALS. "A1" IS DEFINED AS THE DISTANCE FROM THE SEATING PLANE TO THE
- LOWEST POINT ON THE PACKAGE BODY.

DIM	MILLIMETERS		
D	MIN.	NOM.	MAX.
Α	2.20	2.30	2.40
A1	1.70	1.80	1.90
b	0.70	0.80	0.90
b1	9.70	9.80	9.90
b2	0.35	0.45	0.55
С	0.40	0.50	0.60
c1	0.10	_	_
D	10.28	10.38	10.48
D/2	5.09	5.19	5.29
D1	10.98	11.08	11.18
D2	3.20	3.30	3.40
D3	2.60	2.70	2.80
D4	4.45	4.55	4.65
D5	3.20	3.30	3.40
D6	0.55	0.65	0.75
E	9.80	9.90	10.00
E1	7.30	7.40	7.50
E2	0.30	0.40	0.50
E3	9.36	9.46	9.56

ДІМ	MILLIMETERS		
Diw	MIN.	NOM.	MAX.
E4	8.20	8.30	8.40
E5	7.40	7.50	7.60
E6	1.10	1.20	1.30
е		1.20 BSC	;
e/2	(0.60 BSC	;
e1		3.40 BSC	
Н	11.58	11.68	11.78
H/2	5.74	5.84	5.94
H1	7.15 BSC		
L	1.90	2.00	2.10
L1	0.60	0.70	0.80
L2	0.50	0.60	0.70
L3	0.70	0.80	0.90
θ	0°	_	12°
aaa	0.20		
bbb	0.25		
ccc	0.20		
ddd	0.20		
eee	0.10		

GENERIC MARKING DIAGRAM*

AYWWZZ XXXXXXX XXXXXXX

Α = Assembly Location

= Year

WW = Work Week

= Assembly Lot Code ZΖ XXXX = Specific Device Code *This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "■", may or may not be present. Some products may not follow the Generic Marking.

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DESCRIPTION:

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